

PH2925U

N-channel TrenchMOS ultra low level FET

Rev. 04 — 24 February 2009

Product data sheet

1. Product profile

1.1 General description

Ultra low level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Higher operating power due to low thermal resistance
- Interfaces directly with low voltage gate drivers

Low conduction losses due to low on-state resistance

1.3 Applications

- DC-to-DC convertors
- Notebook computers

- Portable equipment
- Switched-mode power supplies

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	25	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 4.5 \text{ V};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	100	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	62.5	W
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 4.5 \text{ V}; I_D = 50 \text{ A};$ $V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	-	20.2	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 8</u> ; see <u>Figure 9</u>	-	2.3	3	mΩ

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2. Pinning information

Table 2.	Pinning	information					
Pin	Symbol	Description	Simplified outline	Graphic symbol			
1	S	source		_			
2	S	source	mb				
3	S	source					
4	G	gate	Q;				
mb	D	mounting base; connected to drain	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	mbb076 S			
			SOT669 (LFPAK)				

3. Ordering information

Table 3.	Orderii	ng information		
Type number		Package		
		Name	Description	Version
PH2925U		LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

4. Limiting values

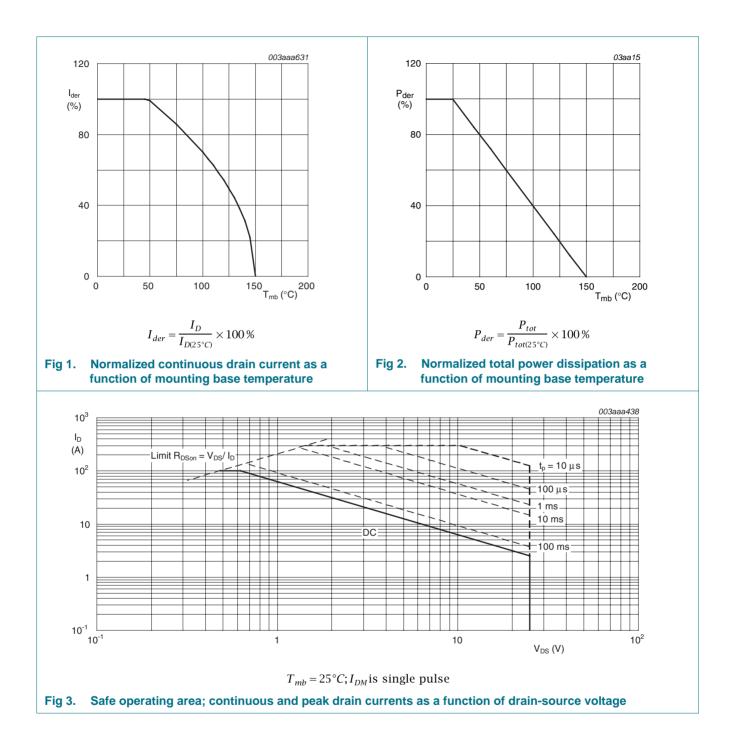
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		o y ()			
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	25	V
V _{DGR}	drain-gate voltage	$T_j \le 150 \text{ °C}; T_j \ge 25 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	25	V
V _{GS}	gate-source voltage		-10	10	V
I _D	drain current	V _{GS} = 4.5 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	70	А
		V_{GS} = 4.5 V; T_{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	100	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	300	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	62.5	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
I _S	source current	T _{mb} = 25 °C	-	52	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	150	А
Avalanche	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_{D} = 70.7 A; V_{sup} ≤ 25 V; unclamped; t_{p} = 0.22 ms; R_{GS} = 50 Ω	-	250	mJ

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5. Thermal characteristics

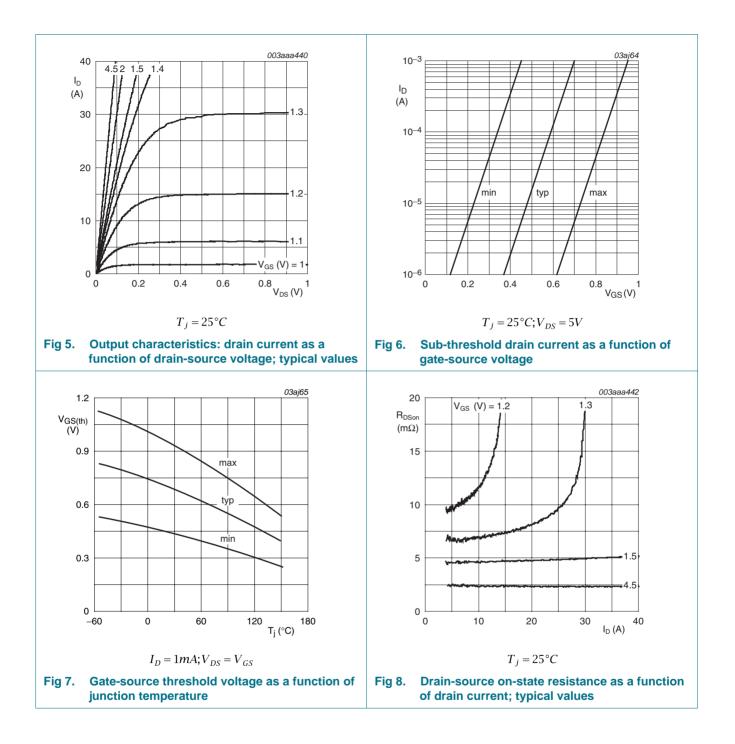
Symbol	Parameter	Conditions			Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	n see <u>Figure 4</u>	see <u>Figure 4</u>		-	- 2	2	K/W
10							003aaa439	
Z _{th(j-mb)} (K/W)								
1	:δ = 0.5							
	0.2				P		$\delta = \frac{t_p}{T}$	
	0.1 0.05 0.02 single pulse							
10 ⁻¹ 1(10 ⁻³	10 ⁻²	10)-1	t _p (s)	1	

6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	22.5	-	-	V
	breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	25	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 6</u> ; see <u>Figure 7</u>	-	-	1.2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C};$ see <u>Figure 6</u> ; see <u>Figure 7</u>	0.25	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 6</u>	0.45	0.7	0.95	V
I _{DSS}	drain leakage current	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	500	μΑ
		$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.06	1	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	20	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	20	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 4.5 V; I _D = 25 A; T _j = 150 °C; see <u>Figure 8</u> ; see <u>Figure 9</u>	-	3.6	4.8	mΩ
		$V_{GS} = 2.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}$	-	3.2	4.2	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C; see Figure 8; see Figure 9	-	2.3	3	mΩ
R _G	internal gate resistance (AC)	f = 1 MHz; T _j = 25 °C	-	1.55	-	Ω
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 50 \text{ A}; V_{DS} = 10 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	92	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } Figure 10; \text{ see } Figure 11$	-	12	-	nC
Q _{GD}	gate-drain charge		-	20.2	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 50 \text{ A}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see Figure 10; see Figure 11	-	1.6	-	V
C _{iss}	input capacitance	V_{DS} = 10 V; V_{GS} = 0 V; f = 1 MHz;	-	6150	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	1170	-	pF
C _{rss}	reverse transfer capacitance		-	814	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 10 V; R_{L} = 1 Ω ; V_{GS} = 4.5 V;	-	30	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \ \Omega; T_j = 25 \ ^{\circ}C$	-	80	-	ns
t _{d(off)}	turn-off delay time		-	258	-	ns
t _f	fall time		-	114	-	ns
Source-di	rain diode					
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see Figure 13	-	0.72	1.2	V
t _{rr}	reverse recovery time	I_S = 20 A; dI _S /dt = -100 A/µs; V _{GS} = 0 V; V _{DS} = 25 V	-	60	-	ns

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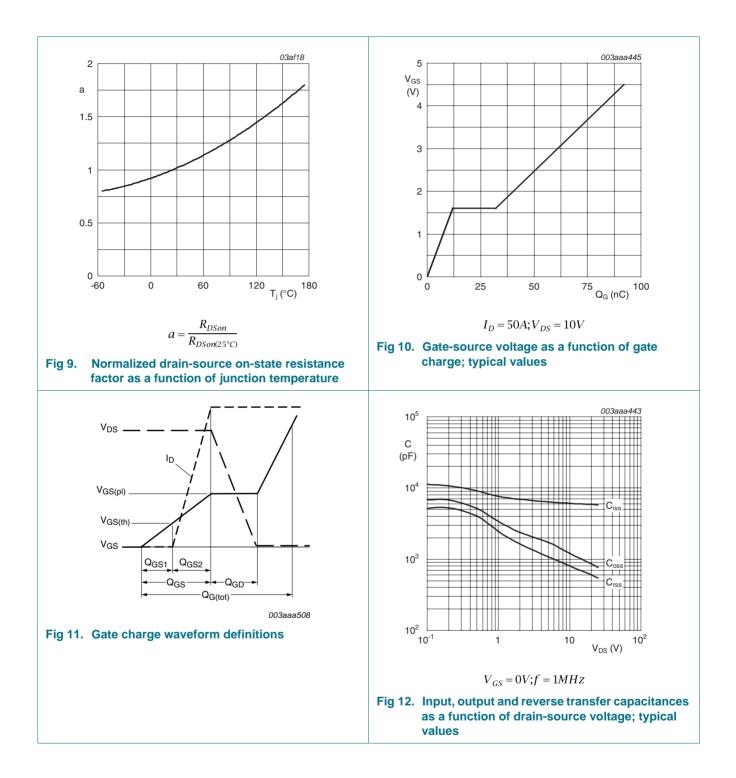
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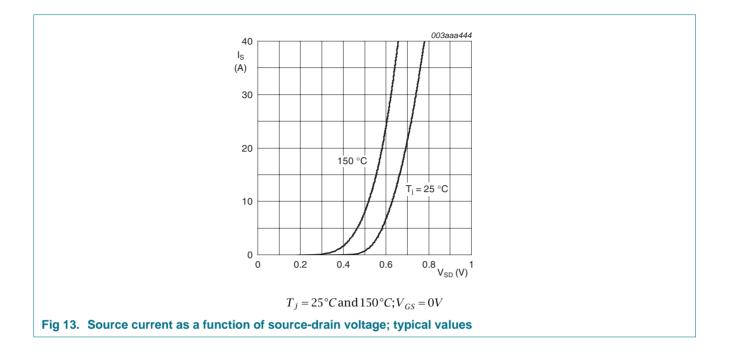
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7. Package outline

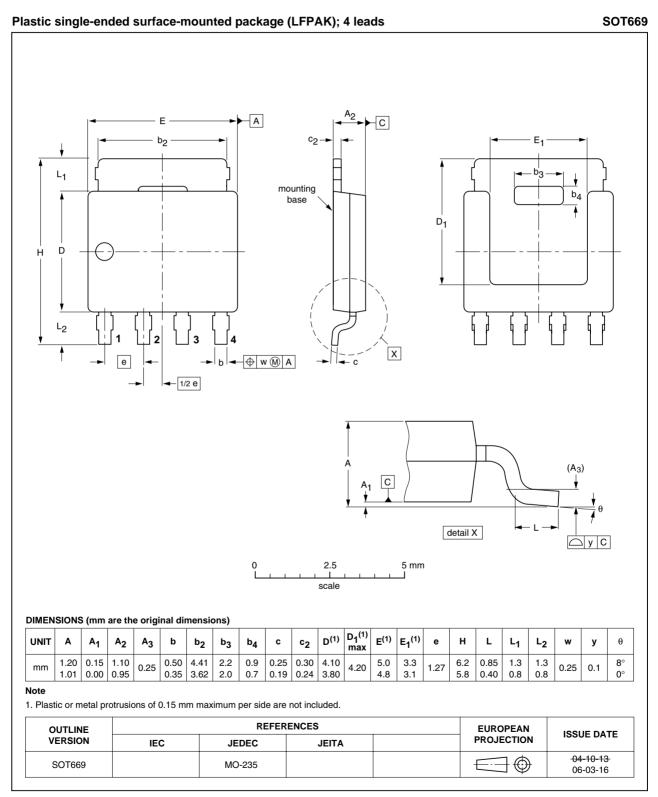


Fig 14. Package outline SOT669 (LFPAK)

Product data sheet

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PH2925U_4	20090224	Product data sheet	-	PH2925U_3
Modifications:		t of this data sheet has be of NXP Semiconductors.	een redesigned to compl	y with the new identity
	 Legal texts 	s have been adapted to th	e new company name v	vhere appropriate.
PH2925U_3	20051129	Product data sheet	-	PH2925U-02
PH2925U-02 (9397 750 13064)	20040408	Product data	-	PH2925U-01
PH2925U-01 (9397 750 11407)	20030502	Product data	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

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